Preferred Device

## Power MOSFET 200 mA, 50 V N-Channel SOT-23

Typical applications are DC–DC converters, power management in portable and battery–powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

#### Features

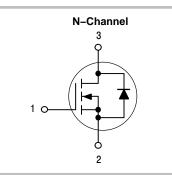
- Pb–Free Packages are Available
- Low Threshold Voltage (V<sub>GS(th)</sub>: 0.5 V–1.5 V) Makes it Ideal for Low Voltage Applications
- Miniature SOT-23 Surface Mount Package Saves Board Space

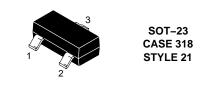


## **ON Semiconductor®**

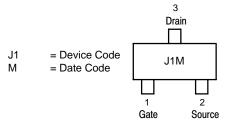
http://onsemi.com

200 mA, 50 V R<sub>DS(on)</sub> = 3.5 Ω





#### MARKING DIAGRAM & PIN ASSIGNMENT



#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
BSS138LT1	SOT-23	3000 Tape & Reel
BSS138LT1G	SOT-23 (Pb-Free)	3000 Tape & Reel
BSS138LT3	SOT-23	10,000 Tape & Reel
BSS138LT3G	SOT-23 (Pb-Free)	10,000 Tape & Reel

<sup>+</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

**Preferred** devices are recommended choices for future use and best overall value.

#### **MAXIMUM RATINGS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{\text{DSS}}$	50	Vdc
Gate-to-Source Voltage - Continuous	$V_{GS}$	± 20	Vdc
Drain Current – Continuous @ $T_A = 25^{\circ}C$ – Pulsed Drain Current ( $t_p \le 10 \ \mu s$ )	I <sub>D</sub> I <sub>DM</sub>	200 800	mA
Total Power Dissipation @ $T_A = 25^{\circ}C$	PD	225	mW
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	– 55 to 150	°C
Thermal Resistance – Junction-to-Ambient	$R_{\thetaJA}$	556	°C/W
Maximum Lead Temperature for Soldering Purposes, for 10 seconds	ΤL	260	°C

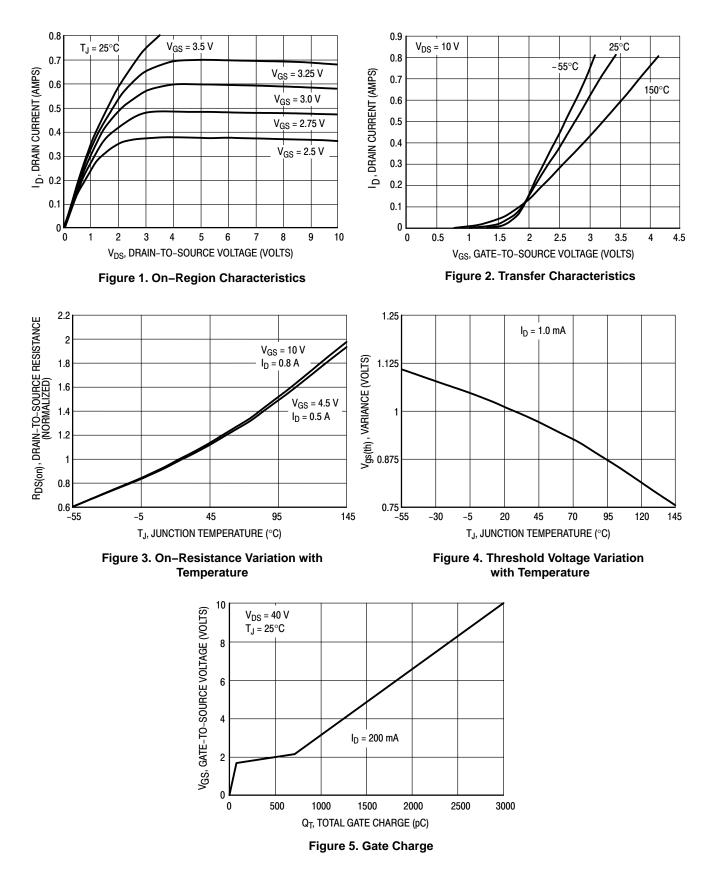
Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

### **ELECTRICAL CHARACTERISTICS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

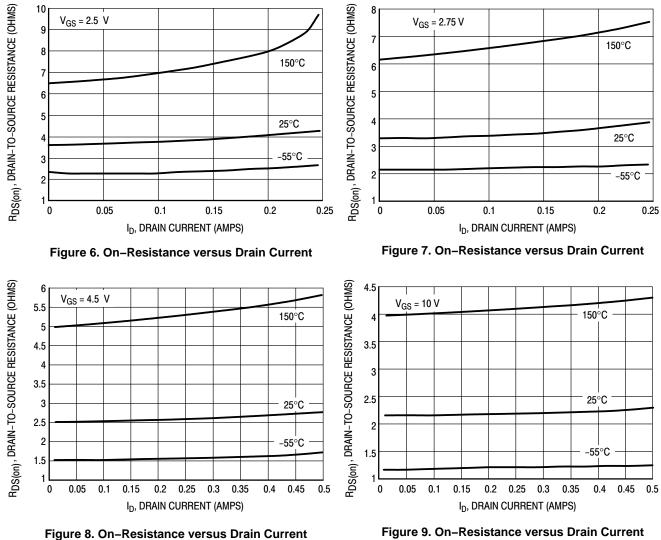
Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS		·	-	•		·
Drain–to–Source Breakdown Voltage ( $V_{GS} = 0 \text{ Vdc}, I_D = 250 \mu \text{Adc}$ )		V <sub>(BR)DSS</sub>	50	-	-	Vdc
Zero Gate Voltage Drain Current $(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 50 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$		I <sub>DSS</sub>	-		0.1 0.5	μAdc
Gate–Source Leakage Current (V <sub>GS</sub> = $\pm$ 20 Vdc, V <sub>DS</sub> = 0 Vdc)		I <sub>GSS</sub>	-	-	±0.1	μAdc
ON CHARACTERISTICS (Note 1)						•
Gate-Source Threshold Voltage ( $V_{DS} = V_{GS}$ , $I_D = 1.0$ mAdc)		V <sub>GS(th)</sub>	0.5	-	1.5	Vdc
Static Drain-to-Source On-Resistance $(V_{GS} = 2.75 \text{ Vdc}, I_D < 200 \text{ mAdc}, T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C})$ $(V_{GS} = 5.0 \text{ Vdc}, I_D = 200 \text{ mAdc})$		r <sub>DS(on)</sub>		5.6 -	10 3.5	Ohms
Forward Transconductance $(V_{DS} = 25 \text{ Vdc}, I_D = 200 \text{ mAdc}, f = 1.0 \text{ kHz})$		9 <sub>fs</sub>	100	-	-	mmhos
DYNAMIC CHARACTERISTICS		•				
Input Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0, f = 1 \text{ MHz})$	C <sub>iss</sub>	_	40	50	pF
Output Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0, f = 1 \text{ MHz})$	C <sub>oss</sub>	-	12	25	
Transfer Capacitance	$(V_{DG} = 25 \text{ Vdc}, V_{GS} = 0, f = 1 \text{ MHz})$	C <sub>rss</sub>	-	3.5	5.0	1
SWITCHING CHARACTERISTICS	(Note 2)	•		•	•	•
Turn-On Delay Time		t <sub>d(on)</sub>	_	-	20	ns
Turn-Off Delay Time	$(V_{DD} = 30 \text{ Vdc}, I_D = 0.2 \text{ Adc},)$	t <sub>d(off)</sub>	-	-	20	

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperature.

#### **TYPICAL ELECTRICAL CHARACTERISTICS**



#### **TYPICAL ELECTRICAL CHARACTERISTICS**



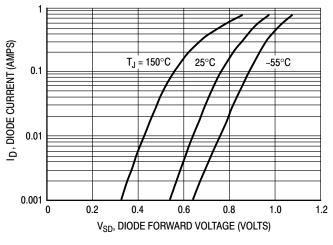


Figure 10. Body Diode Forward Voltage

Figure 9. On-Resistance versus Drain Current

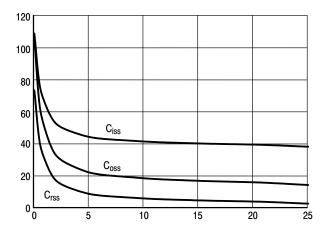
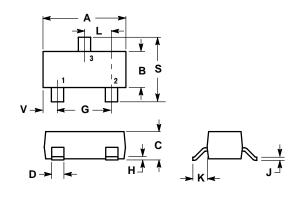


Figure 11. Capacitance

#### PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 **ISSUE AH** 



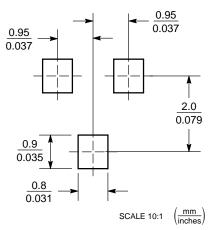
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JIES:
IDMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
CONTROLLING DIMENSION: INCH.
MAXIMUM LEAD THICKNESS INCLUDES LEAD MAXIMUM LEAD THICKNESS INCLUDES LEAD INISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL
. 318-03 AND -07 OBSOLETE, NEW STANDARD 318-08.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.1102	0.1197	2.80	3.04	
В	0.0472	0.0551	1.20	1.40	
С	0.0350	0.0440	0.89	1.11	
D	0.0150	0.0200	0.37	0.50	
G	0.0701	0.0807	1.78	2.04	
Н	0.0005	0.0040	0.013	0.100	
J	0.0034	0.0070	0.085	0.177	
К	0.0140	0.0285	0.35	0.69	
L	0.0350	0.0401	0.89	1.02	
S	0.0830	0.1039	2.10	2.64	
٧	0.0177	0.0236	0.45	0.60	

STYLE 21: PIN 1. GATE 2. SOURCE 3. DRAIN

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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